

Notice of References Cited

Application/Control No.

09/805,559

Applicant(s)/Patent Under
Reexamination
TSUNOI ET AL.

Examiner

Joseph Nguyen

Art Unit

2815

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U.S. PATENT DOCUMENTS

*		Document Number	Date	Name	Classification	
		Country Code-Number-Kind Code	MM-YYYY			
	A	US-6172422B1	01-2001	Chigawa et al	257	778
	B	US-5892289	04-1999	Tokuno	257	783
	C	US-				
	D	US-				
	E	US-				
	F	US-				
	G	US-				
	H	US-				
	I	US-				
	J	US-				
	K	US-				
	L	US-				
	M	US-				

FOREIGN PATENT DOCUMENTS

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	N						
	O						
	P						
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NON-PATENT DOCUMENTS

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